TENTATIVE

TOSHIBA PHOTOCOUPLER PHOTO-DIODE

TLP722

The TOSHIBA TLP722 consists of a photo-diode optically coupled to a gallium arsenide infrared emitting diode in a four lead plastic DIP (DIP4).

TLP722: Single circuit

• Cathode-Anode Voltage : 30 V (max)

• Current Transfer Ratio : 0.1% (min)

• Input/Output Isolation Voltage: 4000 V_{rms} (min)

• Operating Temperature Range : −55~100°C

Storage Temperature Range : −55~125°C

UL Recognized : UL1577, E67349

• VDE Approved : VDE0884

Maximum Operating Insulation Voltage: 890 VPK

Maximum Permissible Over Voltage: 8000 VPK

(Note): When a VDE0884 approved type is needed, please designate the "Option (D4)"

SEMKO Approved Product : SS EN60950,

Approved No. 9808324/01

Construction Mechanical Rating

f.dzsc.com

	TLP722 type	TLP722F type
Creepage Distance	7.0 mm	8.0 mm
Clearance	$7.0 \mathrm{mm}$	$8.0\mathrm{mm}$
Insulation Thickness	0.4 mm	0.4 mm

Unit in mm

4 3
4 3
4 3
4 5
7.62 ± 0.25

1.2 ± 0.15

0.5 ± 0.1

1.2 ± 0.15

0.5 ± 0.25

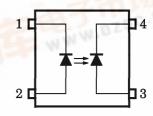
7.85 - 8.80

11-5B2

Weight: 0.28 g

TOSHIBA

PIN CONFIGURATIONS (TOP VIEW)



1: LED CATHODE

2: LED ANODE

3: DETECTOR ANODE

4: DETECTOR CATHODE

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- Gallium arsenide (GaAs) is a substance used in the products described in this document. GaAs dust and fumes are toxic. Do not break, cut or pulverize the product, or use chemicals to dissolve them. When disposing of the products, follow the appropriate regulations. Do not dispose of the products with other industrial waste or with domestic
- garbage.

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TOSHIBA TLP722

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		STMBOL	RATING	UNIT
	Forward Current	$I_{\mathbf{F}}$	25	mA
LED	Forward Current Derating	⊿I _F /°C	-0.45 (Ta $\geq 70^{\circ}$ C)	mA/°C
	Pulse Forward Current	I_{FP}	1 (1 μs pulse, 1000 pps)	mA
	Pulse Forward Current	$I_{ ext{FTP}}$	1 (100 μs pulse, 1000 pps)	A
	Reverse Voltage	v_{R}	5	V
CTOR	Cathode-Anode Voltage	V _{KAO}	30	V
	Anode-Cathode Voltage	VAKO	0.5	V
ΤE	Photodiode Output Current	I_{PB}	100	μ A
DE	Junction Temperature	Tj	125	$^{\circ}\mathrm{C}$
Sto	orage Temperature Range	$\mathrm{T}_{\mathrm{stg}}$	-55~125	$^{\circ}\mathrm{C}$
Op	erating Temperature Range	$T_{ m opr}$	-55~100	°C
Le	ad Soldering Temperature (10 s)	T_{sol}	260 (10 s)	$^{\circ}\mathrm{C}$
Iso	lation Voltage	$BV_{\mathbf{S}}$	4000 (AC, 1 min., R.H. 60%)	V _{rms}

INDIVIDUAL ELECTRICAL CHARACTERISTICS (Ta = 25°C)

	CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Ω	Forward Voltage	$V_{\mathbf{F}}$	$I_{ m F}=16{ m mA}$	_	1.65	1.85	V
闰	Reverse Current	$I_{\mathbf{R}}$	$V_{R} = 5 V$	_	_	10	μ A
	Capacitance	$\mathbf{c_T}$	V = 0, $f = 1 MHz$	_	30	_	pF
R R	Cathode-Anode Breakdown Voltage	V (BR) KAO	$I_{\mathrm{KA}} = 0.1 \mathrm{mA}$	30	_	-	V
CTO]	Anode-Cathode Breakdown Voltage	V (BR) AKO	$I_{ m AK}=0.1 m mA$	0.5	_	_	V
闰	Dark Current	, T, ,	$V_{KA} = 10 V$	_	_	50	nA
DET	Dark Current I _{leak}	$V_{KA} = 10 \text{ V}, \text{ Ta} = 85^{\circ}\text{C}$		_	1	μ A	
	Photodaiode Output Current	I _{PB}	$V = 10 \text{ mA}, V_{KA} = 5 \text{ V}$	10	_	50	μ A
	Capacitance	c_{AK}	V = 0, $f = 1 MHz$	_	10		pF

ISOLATION CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Capacitance (Input to Output)	c_{S}	$V_{ ext{S}} = 0, \text{ f} = 1 \text{ MHz}$		0.8	_	pF
Isolation Resistance	RS	$V_S = 500 V$	1×10^{12}	10^{14}		Ω
	BV_S	AC, 1 minute	4000		_	V _{rms}
Isolation Voltage		AC, 1 second, in oil	_	10000	_	
		DC, 1 minute, in oil	_	10000	_	Vdc